

Description

The HXY50P02D uses advanced trench technology

to provide excellent R_{DS(ON)}, low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

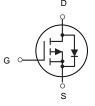


TO-252-2L

General Features

 $V_{DS} = -20V I_{D} = -50A$

 $R_{DS(ON)}$ < 13 m Ω @ V_{GS} =4.5V



P-Channel MOSFET

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HXY50P02D	TO252-2L	50P02 XXX YYYY	2500

Absolute Maximum Ratings (T_c=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units			
VDS	Drain-Source Voltage	-20	V			
VGS	Gate-Source Voltage	Gate-Source Voltage ±12				
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	ous Drain Current, V _{GS} @ 10V ¹ -50				
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	inuous Drain Current, V _{GS} @ 10V ¹ -23				
IDM	Pulsed Drain Current ²	Pulsed Drain Current ² -75				
P _D @T _C =25°C	Total Power Dissipation ⁴	Total Power Dissipation ⁴ 22				
TSTG	Storage Temperature Range	-55 to 150	°C			
TJ	Operating Junction Temperature Range -55 to 150		°C			
R₀JA	Thermal Resistance Junction-ambient ¹ 75		°C/W			
R₀JC	Thermal Resistance Junction-Case ¹	ı-Case ¹ 4.2				



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =-250 u A	-20			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.012		V/°C
		V _{GS} =-4.5V , I _D =-10A		9	13	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-2.5V , I _D =-8A		16	22	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-0.4	-0.7	-1.0	V
△V _{GS(th)}	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID230UA		2.94		mV/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-15V , V _{GS} =0V , T _J =25°C			1	uA
Igss	Gate-Source Leakage Current	V _{GS} = ± 12 V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-10A		43		S
Qg	Total Gate Charge (-4.5V)			35		
Qgs	Gate-Source Charge	V _{DS} =-10V , V _{GS} =-4.5V , I _D =-10A		5.0		nC
Q _{gd}	Gate-Drain Charge			10		
T _{d(on)}	Turn-On Delay Time			12.0		
Tr	Rise Time	V _{DD} =-10V , V _{GS} =-4.5V ,		40.0		no
T _{d(off)}	Turn-Off Delay Time	R _G =3.3Ω, I _D =-10A		30		ns
T _f	Fall Time			10		
Ciss	Input Capacitance			1400		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		350		pF
C _{rss}	Reverse Transfer Capacitance			300		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	\\-=\\-=0\\			-50.0	Α
Ism	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current				Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V
t _{rr}	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,		27		nS
Qrr	Reverse Recovery Charge	T _J =25°C		17.8		nC

Note:

- 1. The data tested by surface mounted on a 1 inch $^2\,\text{FR-4}$ board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leqq 300 us$, duty cycle $\leqq 2\%$
- 3. The power dissipation is limited by 150°C junction temperature
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

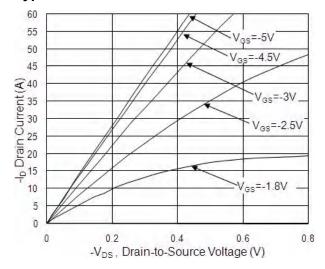


Fig.1 Typical Output Characteristics

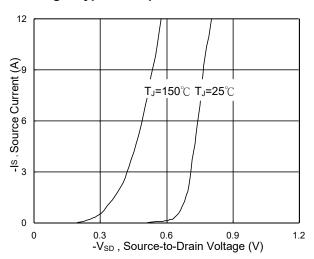


Fig.3 Forward Characteristics of Reverse

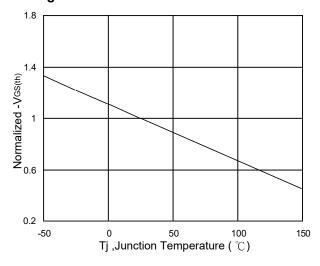


Fig.5 Normalized V_{GS(th)} vs. T_J

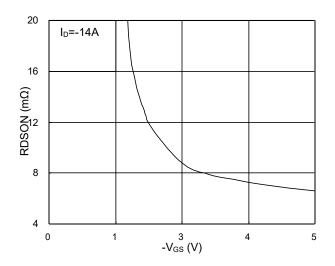


Fig.2 On-Resistance vs. G-S Voltage

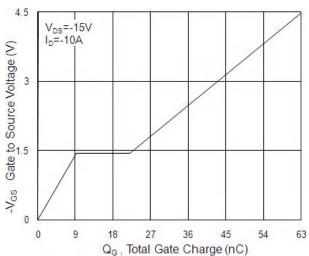


Fig.4 Gate-charge Characteristics

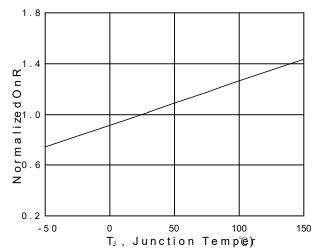
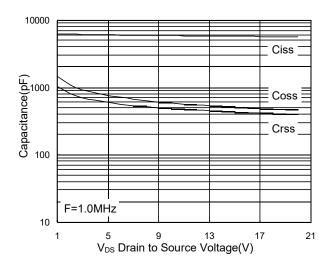


Fig.6 Normalized R_{DSON} vs. T_J





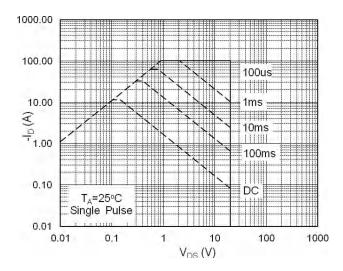


Fig.7 Capacitance

Fig.8 Safe Operating Area

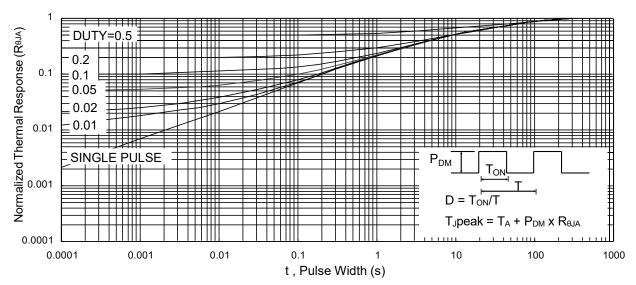
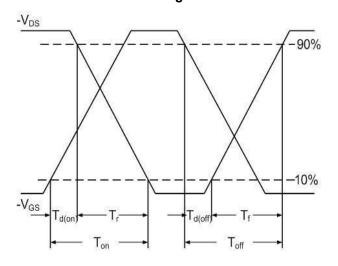


Fig.9 Normalized Maximum Transient Thermal Impedance



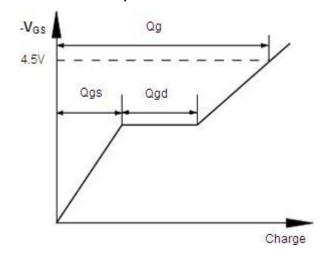
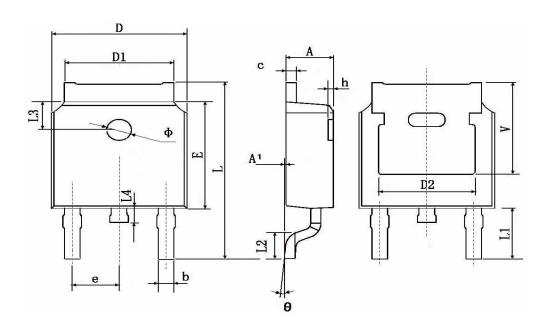


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



TO252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830 TYP.		0.190 TYP.		
Е	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900 TYP.		0.114 TYP.		
L2	1.400	1.700	0.055	0.067	
L3) TYP.	0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350 TYP.		0.211 TYP.		



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